

PNP/PNP matched high power double bipolar transistor 24 October 2014 Product data sheet

1. General description

PNP/PNP high power matched double bipolar transistor in a SOT1205 (LFPAK56D) Surface-Mounted Device (SMD) power plastic package. Matched version of PHPT610030PK.

NPN/NPN complement: PHPT610035NK.

2. Features and benefits

- Current gain matching 10 %
- High thermal power dissipation capability
- Suitable for high temperature applications up to 175 °C
- Reduced Printed-Circuit Board (PCB) requirements comparing to transistors in DPAK
- High energy efficiency due to less heat generation
- AEC-Q101 qualified

3. Applications

- Current mirror
- Motor control
- Power management
- Backlighting applications
- Relay replacement
- Differential amplifiers

4. Quick reference data

Table 1. Qu	ick reference data						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per transisto	r						
V _{CEO}	collector-emitter voltage	open base		-	-	-100	V
I _C	collector current			-	-	-3	А
Per transisto	r		1	1	- 1		
R _{CEsat}	collector-emitter saturation resistance	I _C = -2 A; I _B = -200 mA; pulsed; t _p ≤ 300 μs; δ ≤ 0.02; T _{amb} = 25 °C		-	110	180	mΩ





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5. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	E1	emitter TR1		C1 B2 E2
2	B1	base TR1		
3	E2	emitter TR2		
4	B2	base TR2		
5	C2	collector TR2		E1 B1 C2
6	C2	collector TR2		sym138
7	C1	collector TR1	1 2 3 4 LFPAK56D (SOT1205)	
8	C1	collector TR1		

6. Ordering information

Table 3. Ordering information							
Type number	Package						
	Name	Description	Version				
PHPT610035PK	LFPAK56D	Plastic single ended surface mounted package (LFPAK56D); 8 leads	SOT1205				

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7. Limiting values

Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Мах	Unit
Per transist	or		'			
V _{CBO}	collector-base voltage	open emitter		-	-100	V
V _{CEO}	collector-emitter voltage	open base		-	-100	V
V _{EBO}	emitter-base voltage	open collector		-	-8	V
I _C	collector current			-	-3	А
I _{CM}	peak collector current	single pulse; t _p ≤ 1 ms		-	-8	А
I _B	base current			-	-0.5	А
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C	[1]	-	1	W
			[2]	-	2.4	W
			[3]	-	25	W
Per device						
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C	[1]	-	1.25	W
			[2]	-	3	W
			[4]	-	5	W
Tj	junction temperature			-	175	°C
T _{amb}	ambient temperature			-55	175	°C
T _{stg}	storage temperature			-65	175	°C

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

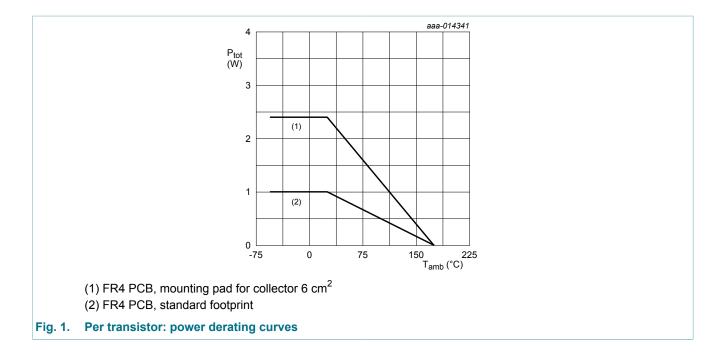
^[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².

[3] Power dissipation from junction to mounting base.

[4] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.

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8. Thermal characteristics

Table 5.Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per transist	tor	1					
R _{th(j-a)}	thermal resistance	in free air	[1]	-	-	150	K/W
from junction to ambient	-	[2]	-	-	62.5	K/W	
R _{th(j-sp)}	thermal resistance from junction to solder point			-	-	6	K/W
Per device		·	· ·	·			
R _{th(j-a)}	thermal resistance	in free air	[1]	-	-	120	K/W
	from junction to ambient		[2]	-	-	50	K/W
	ampient		[3]	-	-	30	K/W

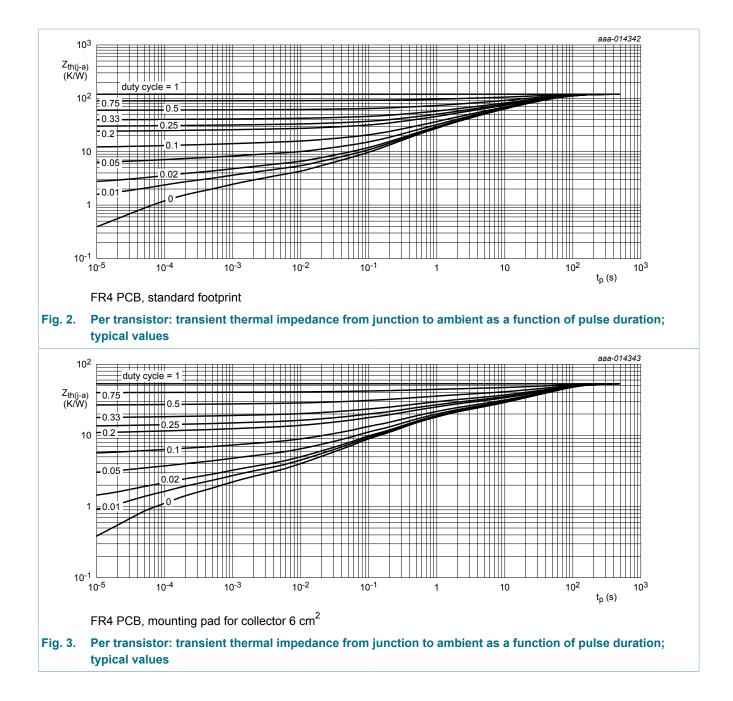
[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

^[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².

[3] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.

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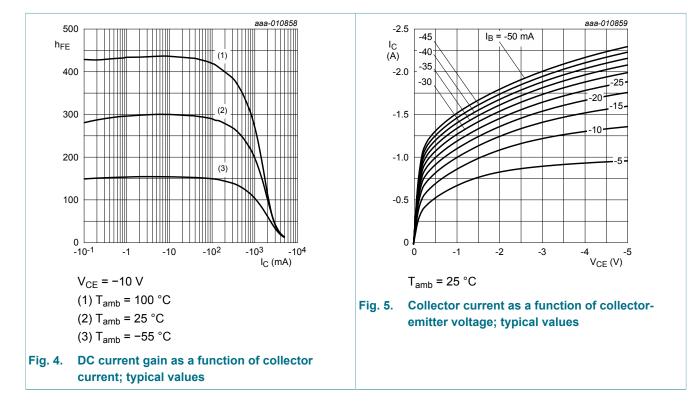
9. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
h _{FE1} /h _{FE2}	h _{FE} matching	V _{CE} = -2 V; I _C = 1 A	0.9	1	1.1	
Per transisto	r				1	
I _{CBO}	collector-base cut-off	V_{CB} = -80 V; I _E = 0 A; T _{amb} = 25 °C	-	-	-100	nA
	current	V_{CB} = -80 V; I _E = 0 A; T _j = 150 °C	-	-	-50	μA
I _{CES}	collector-emitter cut-off current	V_{CE} = -80 V; V_{BE} = 0 V; T_{amb} = 25 °C	-	-	-100	nA
I _{EBO}	emitter-base cut-off current	V_{EB} = -7 V; I _C = 0 A; T _{amb} = 25 °C	-	-	-100	nA
h _{FE} DC	DC current gain	V_{CE} = -10 V; I _C = -500 mA; T _{amb} = 25 °C	150	220	-	
		$\begin{split} V_{CE} &= -10 \text{ V; } I_C = -1 \text{ A; pulsed;} \\ t_p &\leq 300 \mu\text{s; } \delta \leq 0.02\text{; } T_{amb} = 25 ^\circ\text{C} \end{split}$	80	210	-	
		$\begin{split} V_{CE} &= -10 \text{ V; } I_C = -2 \text{ A; pulsed;} \\ t_p &\leq 300 \mu\text{s; } \delta \leq 0.02\text{; } T_{amb} = 25 ^\circ\text{C} \end{split}$	20	100	-	
		V_{CE} = -2 V; I_C = -1 A; T_{amb} = 25 °C	100	200	-	
		V_{CE} = -10 V; I _C = -3 A; pulsed; t _p ≤ 300 µs; δ ≤ 0.02; T _{amb} = 25 °C	10	40	-	
V _{CEsat}	Esat collector-emitter saturation voltage	I_{C} = -500 mA; I_{B} = -50 mA; T_{amb} = 25 °C	-	-70	-110	mV
		$I_{\rm C}$ = -2 A; $I_{\rm B}$ = -200 mA; pulsed;	-	-220	-360	mV
R _{CEsat}	collector-emitter saturation resistance	$t_p \le 300 \ \mu s; \ \delta \le 0.02; \ T_{amb} = 25 \ ^\circ C$	-	110	180	mΩ
V _{BEsat}	base-emitter saturation voltage	$\begin{split} I_{C} &= -1 \text{ A}; I_{B} = -50 \text{ mA}; \text{ pulsed}; \\ t_{p} &\leq 300 \mu\text{s}; \delta \leq 0.02; T_{amb} = 25 ^{\circ}\text{C} \end{split}$	-	-0.91	-1	V
		$\begin{split} I_{C} &= -2 \text{ A}; I_{B} = -200 \text{ mA}; \text{ pulsed}; \\ t_{p} &\leq 300 \mu\text{s}; \delta &\leq 0.02; T_{amb} = 25 ^{\circ}\text{C} \end{split}$	-	-1.02	-1.2	V
V _{BEon}	base-emitter turn-on voltage	$\label{eq:VcE} \begin{array}{l} V_{CE} \texttt{=} \texttt{-2} \; V; \; I_{C} \texttt{=} \texttt{-100} \; mA; \; pulsed; \\ t_{p} \texttt{\leq} \texttt{300} \; \mus; \; \delta \texttt{\leq} \texttt{0.02}; \; T_{amb} \texttt{=} \texttt{25} \; ^{\circ}C \end{array}$	-	-0.68	-0.9	V
t _d	delay time	V_{CC} = -12.5 V; I _C = -1 A; I _{Bon} = -50 mA;	-	20	-	ns
t _r	rise time	I_{Boff} = 50 mA; T_{amb} = 25 °C	-	180	-	ns
t _{on}	turn-on time		-	200	-	ns
t _s	storage time		-	350	-	ns
t _f	fall time		-	220	-	ns
t _{off}	turn-off time		-	570	-	ns

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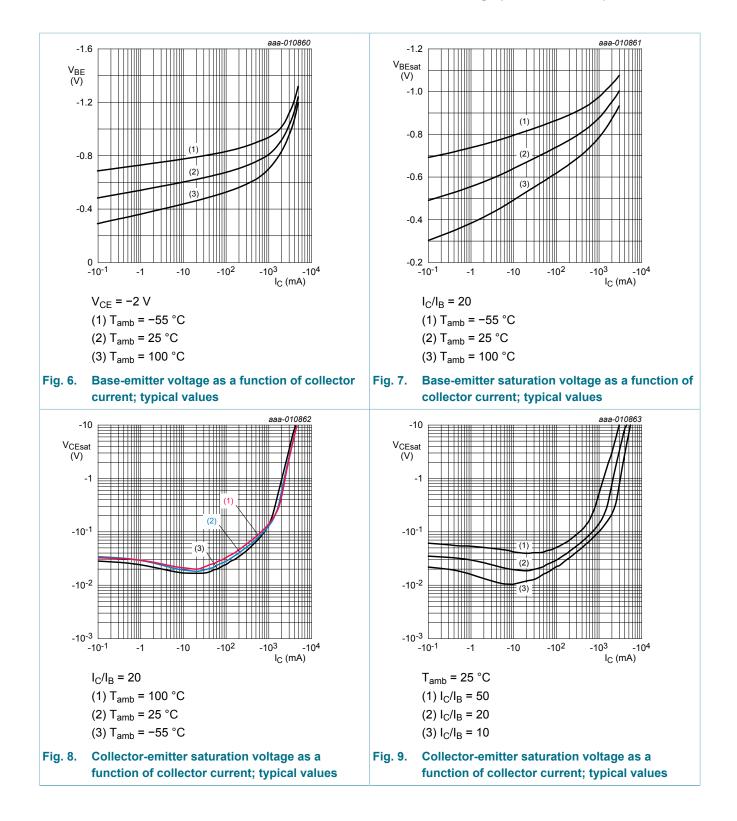
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Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
f _T	transition frequency	V _{CE} = -10 V; I _C = -100 mA; f = 100 MHz; T _{amb} = 25 °C	-	125	-	MHz
C _c	collector capacitance	V_{CB} = -10 V; I _E = 0 A; i _e = 0 A; f = 1 MHz; T _{amb} = 25 °C	-	30	-	pF



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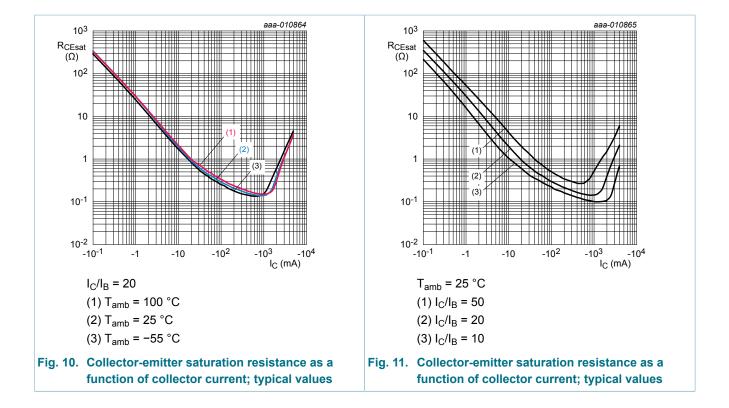
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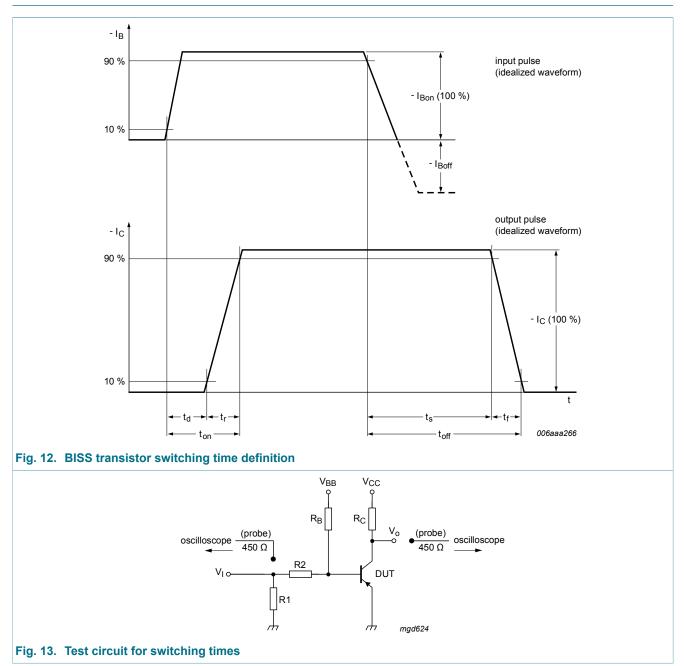
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10. Test information

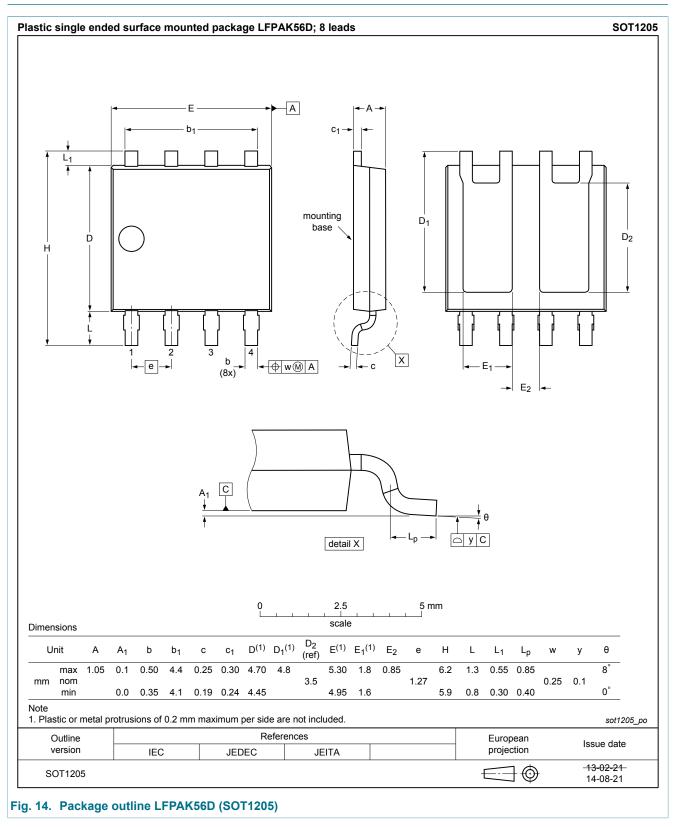


This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101* - *Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

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11. Package outline



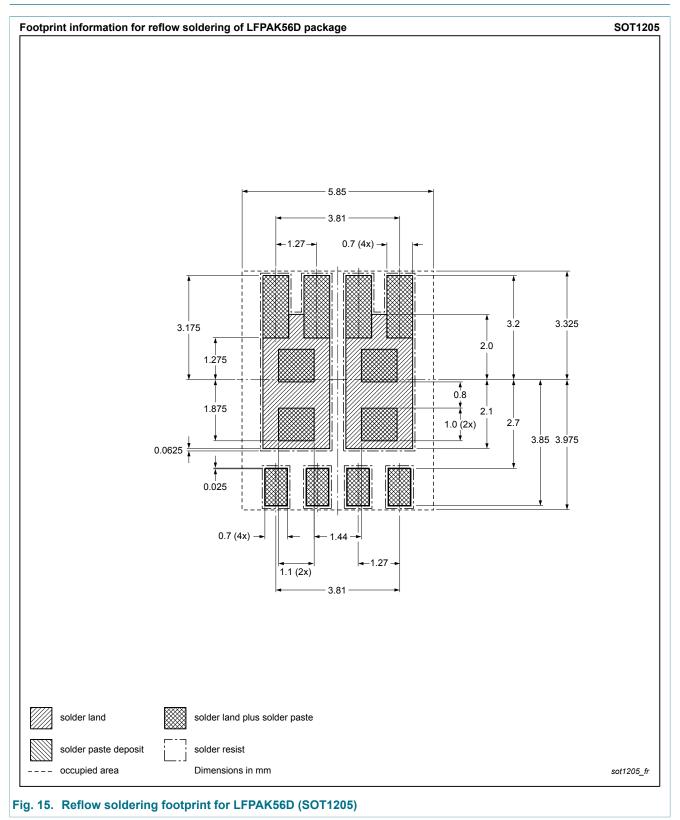
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Product data sheet

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12. Soldering



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13. Revision history

Table 7. Revision history							
Data sheet ID	Release date	Data sheet status	Change notice	Supersedes			
PHPT610035PK v.1	20141024	Product data sheet	-	-			

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14. Legal information

14.1 Data sheet status

Document status [1][2]	Product status [<u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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	Features and benefits

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